

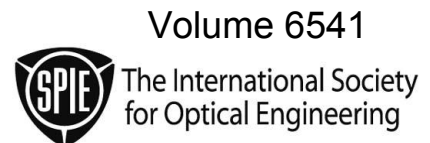
# PROCEEDINGS OF SPIE

## ***Thermosense XXIX***

**Kathryn M. Knettel**  
**Vladimir P. Vavilov**  
**Jonathan J. Miles**  
*Editors*

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